

**Search Notes**

Application/Control No.

10/776,347

Examiner

Yonel Beaulieu

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

3661

**SEARCHED**

Class	Subclass	Date	Examiner
701	41-42	9/26/2006	YB
180	6.2		
	444		
477	1		
475	18		
172	278.9		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST	9/26/2006	YB